
ACP9122: Dual N-Channel Enhancement Mode Field Effect Transistor

datasheet

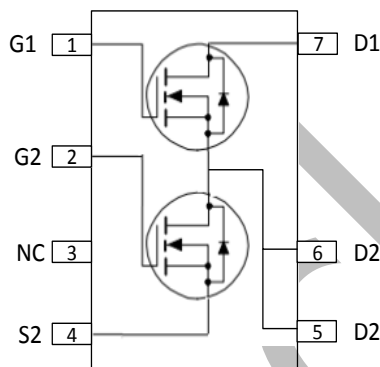
Features

- Output MOSFET voltage: 600V
- Driver output current (DC) : 2A
- $R_{DS(on)}=4.5\ \Omega$ @ $V_{GS}=10V$
- High staturation current
- Operating ambient temperature
- $T_A=-40^{\circ}C$ to $105^{\circ}C$ (G: Industrial application)
- Dual N-channel mos
- package: DIP7/SOP6

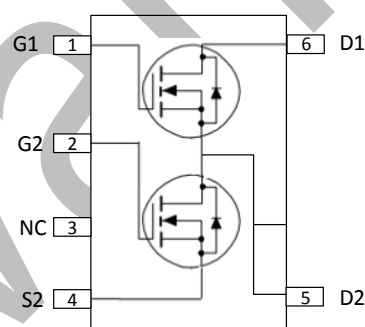
1 Introduction

These dual N-Channel enhancement mode power field effect transistors are particularly suited for high voltage applications for motor driving. This very high density process has been designed to minimize on-state resistance, provide rugged and reliable performance and fast swithing.

The blockdiagram as follows:



Featur 1 DIP7 package



Featur 2 SOP6 package

The absolute maximum rating as follow table shows:

Absolute Maximum Ratings ($T_j = 25^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Rating	Units
Drain-to-Source Voltage	V_{DSX}	600	V
Continuous Drain Current $T_C = 25^\circ\text{C}$	I_D	2	A
Continuous Drain Current $T_C = 100^\circ\text{C}$	I_D	1.2	A
Pulsed Drain Current	I_{DM}^{a1}	8	A
Gate-to-Source Voltage	V_{GS}	± 30	V
Power Dissipation($T_C=25^\circ\text{C}$)	P_{tot}	35	W
Operating Junction	T_j	150	$^\circ\text{C}$
Junction to Ambient	J_a	74.29	$^\circ\text{C/W}$
Single Pulse Avalanche Energy	E_{as}	90	mJ

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2 Electrical Characteristics

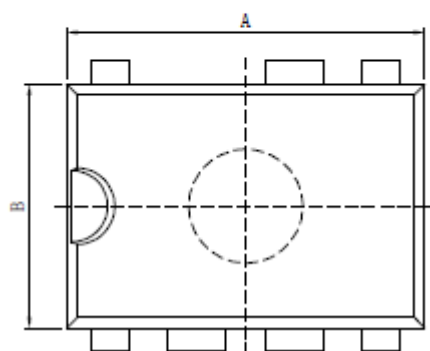
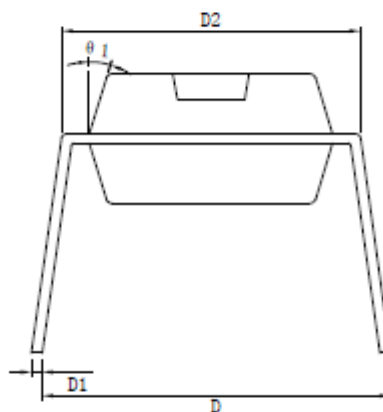
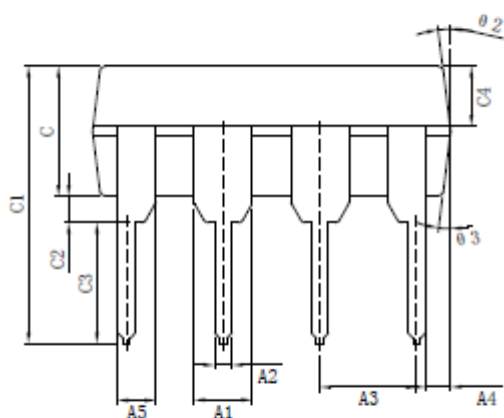
Parameter	Symbol	Test Conditions	Rating			Units
			Min	Typ	Max	
Drain-to-Source Breakdown Voltage	V_{DS}	$V_{GS}=0V, I_D=250\mu A$	600			V
Drain-to-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=1.0A$		4.5	5.0	Ω
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	3.5	4.0	4.5	V
Drain-to-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{DS}=2A$			1.5	V
Drain to Source Leakage Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V, T_c=25^{\circ}C$			1	μA
		$V_{DS}=480V, V_{GS}=0V, T_c=125^{\circ}C$			100	μA
Gate to Source Forward Leakage	$I_{GSS(F)}$	$V_{GS}=+30V$			100	nA
Gate to Source Reverse Leakage	$I_{GSS(R)}$	$V_{GS}=-30V$			-100	nA
Input Capacitance	C_{iss}	$V_{GS}=0V, V_{DS}=25V$ $f=1.0MHz$		438		pF
Output Capacitance	C_{oss}			34		pF
Reverse Transfer Capacitance	C_{rss}			1.3		pF
a: Pulse width $t_p \leq 300\mu s, \delta \leq 2\%$						
Parameter	Symbol	Test Conditions	Rating			Units
			Min	Typ	Max	
Reverse Recovery Time	T_{rr}	$di/dt = 100A/\mu s, I_S = 2A$		45	100	ns
Reverse Recovery Charge	Q_{rr}			50		nC
Reverse Recovery Current	I_{RRM}			2.3		A
a: Pulse width $t_p \leq 300\mu s, \delta \leq 2\%$						

3 Package information

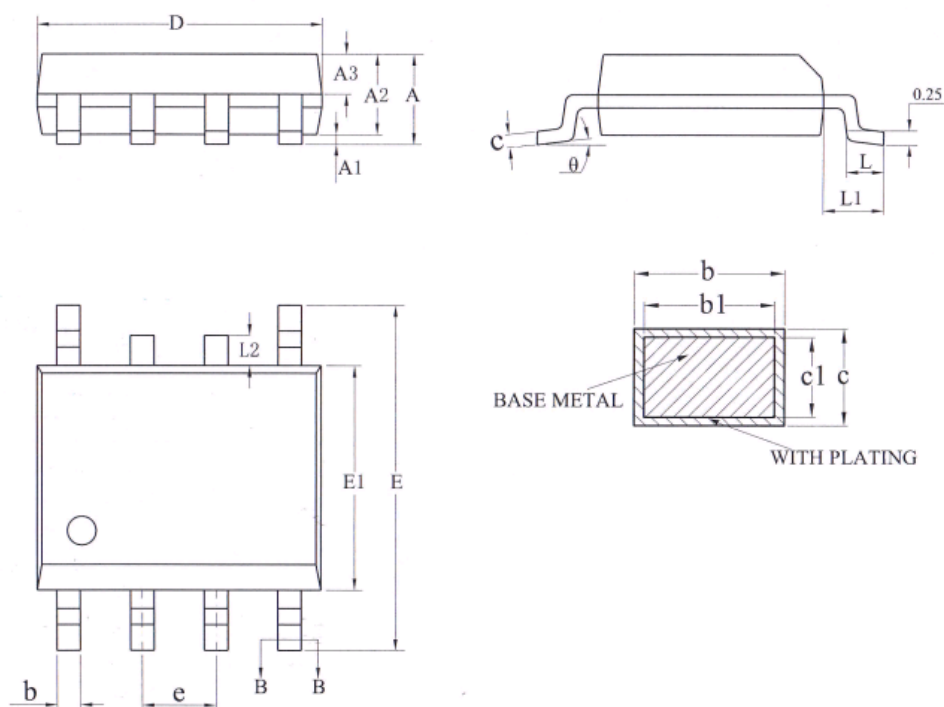
ACP9122 provide DIP7 package.

3.1 DIP7 package information

type	size	min(mm)	max(mm)		min(mm)	max(mm)
A		9.00	9.20	C2	0.50TYP	
A1		1.474	1.574	C3	3.20	3.40
A2		0.41	0.51	C4	1.47	1.57
A3		2.44	2.64	D	8.20	8.80
A4		0.51TYP		D1	0.244	0.264
A5		0.99TYP		D2	7.62	7.87
B		6.10	6.30	θ 1	17° TYP4	
C		3.20	3.40	θ 2	10° TYP4	
C1		7.10	7.30	θ 3	8° TYP	



3.2 SOP6 package information



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	—	—	1.75
A1	0.10	—	0.225
A2	1.30	1.40	1.50
A3	0.60	0.65	0.70
b	0.39	—	0.47
b1	0.38	0.41	0.44
c	0.20	—	0.24
c1	0.19	0.20	0.21
D	4.80	4.90	5.00
E	5.80	6.00	6.20
E1	3.80	3.90	4.00
e	1.27BSC		
L	0.50	—	0.80
L1	1.05REF		
L2	0.30	0.40	0.50
θ	0	—	8°

4 Revision history

version	Name	Date	Changes
V1.0	Daniel	2023-3-1	initial version